

COMPLIANT

## **Dual N-Channel 100 V (D-S) MOSFET**

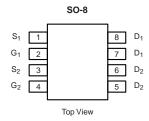
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (mΩ)(Typ.)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
100	70 at V <sub>GS</sub> = 10 V	7	20.5 nC			
100	80 at V <sub>GS</sub> = 4.5 V	]				

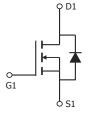
#### **FEATURES**

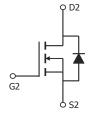
- DT-Trench Power MOSFET
- 100 % Rg and UIS tested
- · High Power and current handing capability
- Super Low Gate Charge

#### **APPLICATIONS**

- Networking DC-DC Power System
- Load Switch







N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	100	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	V		
Ocation of Ducie Organization 150 00/2	T <sub>C</sub> = 25 °C		7	А	
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>C</sub> = 100 °C	I <sub>D</sub>	5.2		
Pulsed Drain Current <sup>b</sup>	I <sub>DM</sub>	28			
Single Avalanche Energy		E <sub>AS</sub>	6.5	mJ	
Maximum Bayer Dissinations	T <sub>C</sub> = 25 °C	В	2	W	
Maximum Power Dissipation <sup>c</sup>	T <sub>C</sub> = 100 °C	P <sub>D</sub>	0.8		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) <sup>d</sup>	R <sub>thJA</sub>	R <sub>thJA</sub> 85			
Junction-to-Case (Drain)	R <sub>thJC</sub>	62	- C/W		

#### Notes

- a. Calculated continuous current based on maximum allowablejunction temperature.
- b. Repetitive rating; pulse width limited by max. junction temperature.
- c. Pd is based on max. junction temperature, using junction-case thermal resistance.
- d. The value of R<sub>0JA</sub> is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper,in a still air environment with Ta=25 °C.



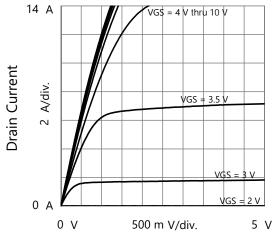
SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$			-	-	V	
Gate Threshold Voltage	V <sub>GS(th)</sub>			-	2.5	V	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	± 100	nA	
Zero Gate Voltage Drain Current		$V_{DS} = 100  V$ , $V_{GS} = 0  V$	1	-	1	μΑ	
Zero date voltage Drain Gunerit	I <sub>DSS</sub>	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$	-	-	100		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	7	-	-	Α	
Drain-Source On-State Resistance a	Brack	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	70	98	mΩ	
Drain-Goulde On-Glate Hesistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 5 A		80	120		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 5 \text{ V}, I_{D} = 5 \text{ A}$	-	15	-	S	
Dynamic <sup>b</sup>				•			
Input Capacitance	C <sub>iss</sub>		-	1150	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}$	=	32	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	26	-		
Total Gate Charge <sup>c</sup>	Qg		-	20.5	-	nC	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	2.5	-		
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$		-	4	-		
Gate Resistance	Rg	f = 1 MHz	-	1.6	-	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>		-	10	-		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, I_D = 5 \text{ A}, R_g = 3\Omega$	-	3	-		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	V <sub>GS</sub> = 10 V	-	15	-	ns	
Fall Time <sup>c</sup>	t <sub>f</sub>		-	4	-		
Drain-Source Body Diode Ratings and	Characterist	ics <sup>b</sup> (T <sub>C</sub> = 25 °C)		•			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	7	Α	
Pulsed Current	I <sub>SM</sub>		-	-	28	Α	
Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>F</sub> = 1 A, V <sub>GS</sub> = 0 V	-	-	1.2	V	
everse Recovery Time t <sub>rr</sub>		L E A di/d+ 100 A/:	-	20	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = 5 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	-	26	-	nC	

#### Notes

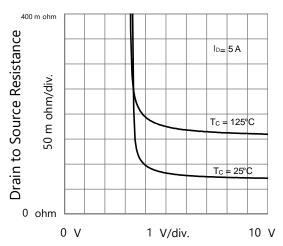
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### TYPICAL CHARACTERISTICS (25 C, unless otherwise noted)

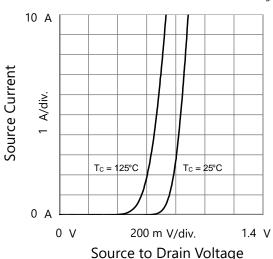


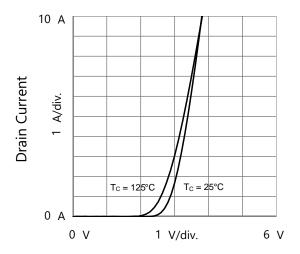
Drain to Source Voltage Output Characteristics



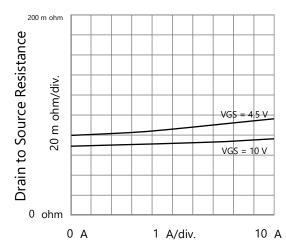
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

**Body Diode Forward Characteristics** 



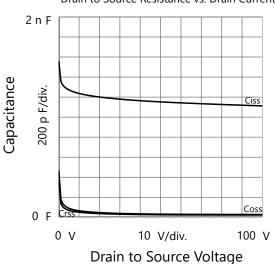


Gate to Source Voltage Transfer Characteristics



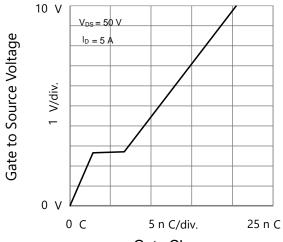
Drain Current
Drain to Source Resistance vs. Drain Current

Capacitances

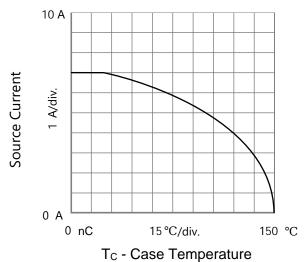


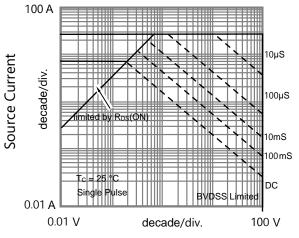


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

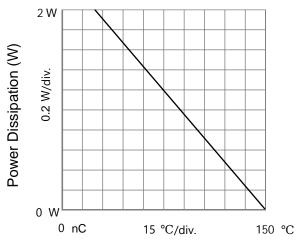


Gate Charge Gate to Source Voltage vs. GateCharge

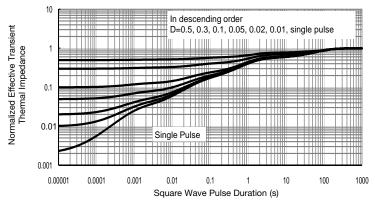




Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



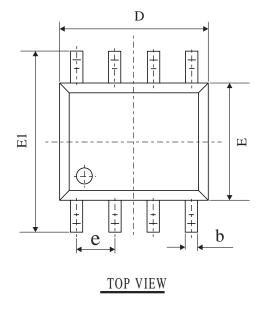
T<sub>C</sub> - Case Temperature

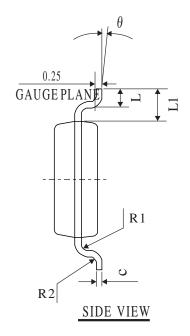


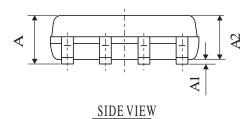
Normalized Thermal Transient Impedance, Junction-to-Ambient



# **SOP-8 PACKAGE OUTLINE**







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	1.30	1.60	1.85
A1	0.03	0.15	0.28
A2	1.20	1.45	1.70
ь	0.26	0.40	0.54
С	0.132	0.203	0.273
D	4.50	4.90	5.30
Е	3.50	3.00	4.30
E1	5.50	6.00	6.50
L	0.30	0.70	1.10
θ	2°	4°	6°
L1	1.04REF		
e	1.27BSC		
R1	0.07TYP		
R2	0.07TYP		

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